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WeEn Semiconductors



BYV32E-150

Dual rugged ultrafast rectifier diode, 20 A, 150 V Rev. 04 — 2 March 2009 Prod

Product data sheet

Product profile 1.

1.1 General description

Ultrafast dual epitaxial rectifier diode in a SOT78 (TO-220AB) plastic package.

1.2 Features and benefits

- High reverse voltage surge capability
- High thermal cycling performance
- Low thermal resistance

- Soft recovery characteristic minimizes power consuming oscillations
- Very low on-state loss

1.3 Applications

Output rectifiers in high-frequency switched-mode power supplies

1.4 Quick reference data

Table 1. **Quick reference**

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{RRM}	repetitive peak reverse voltage		-	-	150	V
I _{O(AV)}	average output current	square-wave pulse; δ = 0.5; $T_{mb} \le 115$ °C; both diodes conducting; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	20	Α
I _{RRM}	repetitive peak reverse current	$t_p = 2 \ \mu s; \ \delta = 0.001$	-	-	0.2	Α
V_{ESD}	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 $k\Omega$; all pins	-	-	8	kV
Dynamic characteristics						
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; ramp recovery; see Figure 5	-	20	25	ns
		$I_R = 0.5 \text{ A}$; $I_F = 1 \text{ A}$; $T_j = 25 \text{ °C}$; step recovery; measured at reverse current = 0.25 A; see Figure 6	-	10	20	ns
Static ch	aracteristics					
V _F	forward voltage	$I_F = 8 \text{ A}$; $T_j = 150 \text{ °C}$; see Figure 4	-	0.72	0.85	V





2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode 1		
2	K	cathode	mb	A1 + + A2
3	A2	anode 2		<u> </u>
mb	Κ	mounting base; cathode	1 2 3 SOT78	sym125
			(TO-220AB; SC-46)	

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BYV32E-150	TO-220AB; SC-46	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78		

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{RRM}	repetitive peak reverse voltage		-	150	V
V_{RWM}	crest working reverse voltage		-	150	V
V_R	reverse voltage	DC	-	150	V
I _{O(AV)}	average output current	square-wave pulse; δ = 0.5; $T_{mb} \le$ 115 °C; both diodes conducting; see Figure 1; see Figure 2	-	20	Α
I _{FRM}	repetitive peak forward current	$\bar{\delta}$ = 0.5; t_p = 25 μ s; T_{mb} ≤ 115 °C; per diode	-	20	Α
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	125	Α
		t_p = 8.3 s; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	137	Α
I _{RRM}	repetitive peak reverse current	δ = 0.001; t_p = 2 μ s	-	0.2	Α
I _{RSM}	non-repetitive peak reverse current	$t_p = 100 \ \mu s$	-	0.2	Α
T _{stg}	storage temperature		-40	150	°C
Tj	junction temperature		-	150	°C
V _{ESD}	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 k Ω ; all pins	-	8	kV

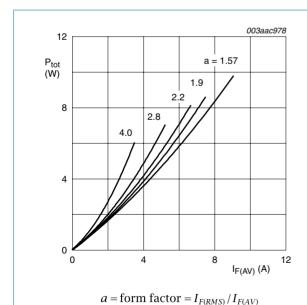
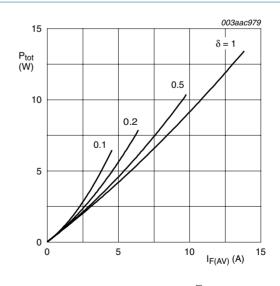


Fig 1. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values



 $I_{F(AV)} = I_{F(RMS)} \times \sqrt{\delta}$

Fig 2. Forward power dissipation as a function of average forward current; square waveform; maximum values

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5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting	with heatsink compound; both diodes conducting	-	-	1.6	K/W
	base	with heatsink compound; per diode; see Figure 3	-	-	2.4	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient		-	60	-	K/W

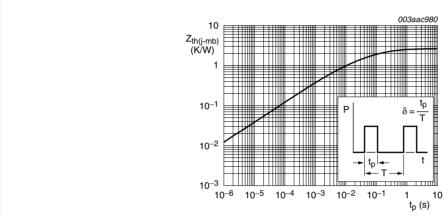
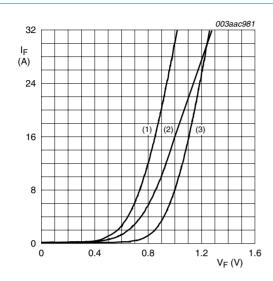


Fig 3. Transient thermal impedance from junction to mounting base as a function of pulse width

6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _F	forward voltage	I _F = 8 A; T _j = 150 °C; see <u>Figure 4</u>	-	0.72	0.85	V
		I _F = 20 A; T _j = 25 °C	-	1	1.15	V
I_R	reverse current	V _R = 150 V; T _j = 100 °C	-	0.2	0.6	mA
		V _R = 150 V; T _j = 25 °C	-	6	30	μΑ
Dynamic	characteristics					
Q _r	recovered charge	$I_F = 2 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 20 \text{ A/}\mu\text{s}; $ $T_j = 25 \text{ °C}$	-	8	12.5	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; ramp recovery; $T_j = 25 \text{ °C}$; see Figure 5	-	20	25	ns
		$I_F = 1 \text{ A}$; $I_R = 0.5 \text{ A}$; step recovery; measured at reverse current = 0.25 A; $T_j = 25 ^{\circ}\text{C}$; see Figure 6	-	10	20	ns
V_{FR}	forward recovery voltage	$I_F = 1 \text{ A}$; $dI_F/dt = 10 \text{ A/}\mu\text{s}$; see Figure 7	-	-	1	V



- (1) $T_j = 150$ °C; typical values
- (2) $T_j = 150$ °C; maximum values
- (3) $T_j = 25$ °C; maximum values

Fig 4. Forward current as a function of forward voltage

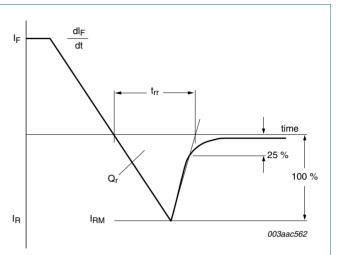


Fig 5. Reverse recovery definitions; ramp recovery

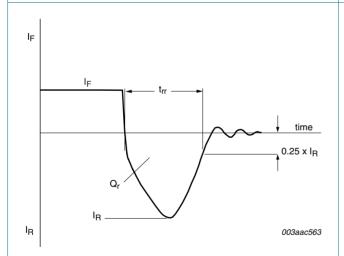


Fig 6. Reverse recovery definitions; step recovery

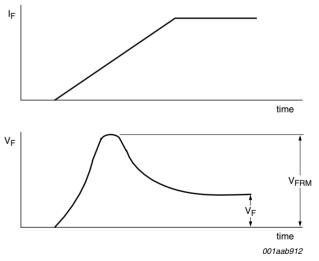
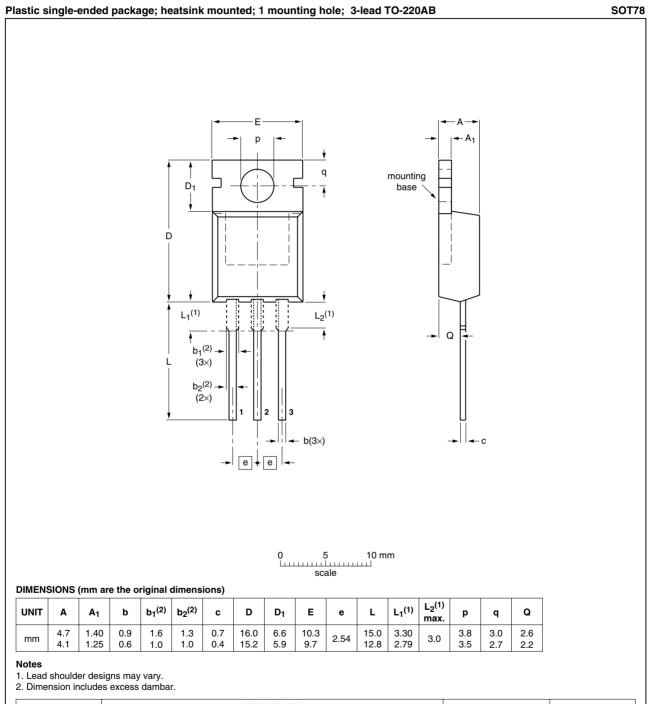


Fig 7. Forward recovery definitions

7. Package outline



	OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION		IEC	JEDEC JEITA		PROJECTION	ISSUE DATE
	SOT78		3-lead TO-220AB	SC-46		08-04-23 08-06-13

Fig 8. Package outline SOT78 (TO-220AB)

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BYV32E-150_4	20090302	Product data sheet	-	BYV32E_SERIES_3
Modifications:		of this data sheet has been of NXP Semiconductors.	en redesigned to compl	y with the new identity
	 Legal texts 	have been adapted to the	new company name v	vhere appropriate.
	 Package or 	utline updated.		
	 Type numb 	er BYV32E-150 separated	d from data sheet BYV3	32E_SERIES_3
BYV32E_SERIES_3	20010301	Product specification	-	BYV32E_SERIES_2
BYV32E_SERIES_2	19980701	Product specification	-	BYV32EB_SERIES_1
BYV32EB SERIES 1	19960801	Product specification	_	

BYV32E-150

Dual rugged ultrafast rectifier diode, 20 A, 150 V

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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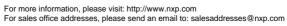
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